

# Implementing Rigorous Defect Control

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## Problem statement

Given the initial-value problem (IVP)

$$x'(t) = f(t, x(t)) \in \mathbb{R}^d \quad x(t_0) = x_0 \quad [t_0, t_{\text{end}}] \quad \text{tol} > 0$$

compute a piecewise polynomial **approximate solution**  $u$

- ▶ continuously differentiable  $t \in [t_0, t_{\text{end}}] \mapsto u(t) = (u_1(t), \dots, u_d(t)) \in \mathbb{R}^d$
- ▶ nearly satisfying the initial condition

Compute **defect**

$$\Delta u(t) = u'(t) - f(t, u(t)) \quad \Delta u(t_0) \stackrel{\text{def}}{=} u(t_0) - x_0$$

**Rigorous** bound

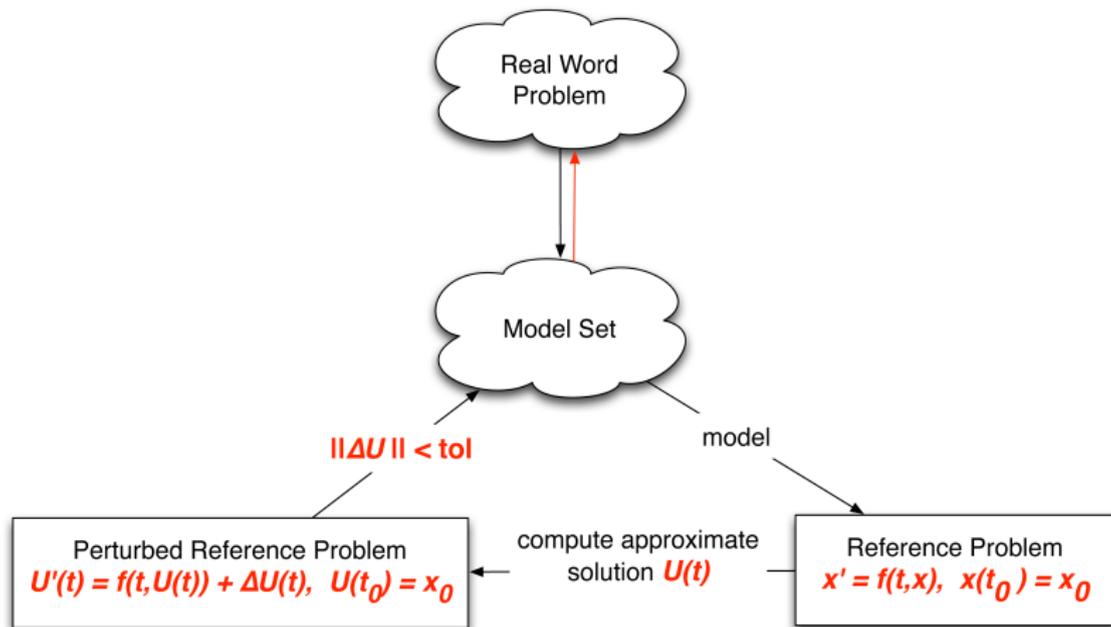
$$\|\Delta u\|_{\infty} \stackrel{\text{def}}{=} \max_{i,t} |\Delta u_i(t)| \leq \text{tol} \quad t \in [t_0, t_{\text{end}}] \quad i = 1, \dots, d$$

- ▶ Rigorous Polynomial Approximation (RPA)
- ▶ Taylor models (TM)
- ▶ Interval Arithmetic (IA)

## Defect control literature

- ▶ Enright advocates asymptotic defect control  
Enright and Coworkers and Students (since 1989)
- ▶ Defect control and ODE boundary value problem  
Enright and Muir, Shampine and Muir (1993-2004)
- ▶ Corless and Corliss outlined rigorous defect control  
Corless and Corliss (1991)

# Residual-based backward error analysis for ODE



## Local residual-based backward error analysis for ODE

Given

$$x'(t) = f(t, x(t)) \quad x(t_n) = x_n \quad \text{tol} > 0$$

compute approximate  $u$  on  $[t_n, t_{n+1}]$  and compute defect

$$\Delta u(t) \stackrel{\text{def}}{=} u'(t) - f(t, u(t)) \quad \Delta u(t_n) \stackrel{\text{def}}{=} u(t_n) - x_n$$

Find stepsize so that  $u$  satisfies on  $[t_n, t_{n+1}]$

$$u'(t) = f(t, u(t)) + \Delta u(t) \quad u(t_n) = x_n \quad \|\Delta u\|_\infty \leq \text{tol}$$

Then  $u$  exactly solves modified problem on  $[t_0, t_{\text{end}}]$

$$u'(t) = f(t, u(t)) + \Delta u(t) \quad u(t_0) = x_0 + \Delta u(t_0) \quad \|\Delta u\|_\infty \leq \text{tol}$$

# Outline

Why defect control

Approximate solution

Our method

Interval arithmetic evaluation

ODETS software

Results

Conclusions

## Backward error vs Forward error

### Forward error

- ▶ Standard ODE-IVP solvers control local error on each step
  - ▶ Local error control can be deceived
  - ▶ No guarantee the global error is within some bounds
- ▶ Interval methods compute rigorous bounds on solution
  - ▶ hard to keep them tight

### Backward error

- ▶ Compute **exact solution** to a modified problem  
Approximate solution solves exactly  $u'(t) = f(t, u(t)) + \Delta u(t)$   
The model is usually an approximation anyhow
- ▶ Monitor and control the maximum magnitude of the defect  
Asymptotically correct defect estimate (Enright)  
Guarantee  $\|\Delta u\|_{\infty} \leq \text{tol}$

# Why now is the right time for defect control

Approximate solution is true solution of modified problem

Defect encapsulates all errors

Bounding real valued function

Well-studied problem in interval analysis

Rigorous Polynomial Approximation (Joldes 2011)

TM arithmetic in one independent variable

Rigorous supremum norm of a polynomial

## Approximate solution

Good numerical ODE solvers for the initial value problem

$$x'(t) = f(t, x(t)) \quad x(t_0) = x_0$$

- ▶ control local error on each step
- ▶ return skeletal solution  $(t_n, x_n)$
- ▶ return a continuously differentiable approximation  $u$  to  $x$

Defect control (DC) methods

- ▶ monitor and control the maximum magnitude of the defect
- ▶ **Asymptotic DC** estimates  $\|\Delta u\|_\infty$  by evaluating it at carefully selected points in each integration interval
- ▶ **Rigorous DC** ensures  $\|\Delta u(t)\| \leq \text{tol}$  on  $[t_0, t_{\text{end}}]$

# Taylor series method

Computation often regarded as expensive

This is not the case

Computing defect inexpensive

Compared to cost of Taylor series method itself

$$u(t) = \sum_{k=0}^K (u)_k (t - t_i)^k \quad \text{where} \quad (u)_k = \frac{1}{k!} (f)_{k-1}$$

Data management: [ApproximateSolution class](#)

## Automatic differentiation via operator overloading

From  $f$  to its Computational Graph, a DAG

Bendtsen and Stauning [FADBAD++, TADIFF ] (1997)

Idea: Taylor arithmetic

- ▶ Assume user equations are elementary functions
- ▶ Construct an efficient computational graph
- ▶ Nodes (basic functions): sin, asin, sqrt, pow, log, exp
- ▶ Edges (basic operators): add, sub, mul, div, composition

Interface to TADIFF: **TaylorExpansion class**

## Method to integrate ODE by time stepping

Given initial condition  $x_n$  at  $t_n$  and stepsize  $h_n$ , take a step to

$$t_{n+1} = t_n + h_n$$

**Phase I.** Compute an approximate polynomial solution

floating-point arithmetic

**Phase II.** Bound the defect

Taylor models and interval arithmetic

**Phase III.** Accept/reject step

floating-point arithmetic

## Phase I: Compute an approximate polynomial solution

(a) We use Taylor series:

$$u(t) = x_n + (x_n)_1(t - t_n) + \cdots + (x_n)_K(t - t_n)^K,$$

- ▶  $(x_n)_k$  are Taylor coefficients at  $t_n$
- ▶ Computed using automatic differentiation and FADBAD++ [Bendtsen and Stauning](#)

(b) Evaluate  $x_{n+1} = u(t_{n+1})$  and interpolate  $f(t_{n+1}, x_{n+1})$ :

$$U(t) = u(t) + \frac{\Delta u(t_{n+1})}{h_n^K}(t - t_n)^{K+1} - \frac{\Delta u(t_{n+1})}{h_n^{K+1}}(t - t_n)^{K+2}$$

This ensures  $\Delta U(t_n) = \Delta U(t_{n+1}) = 0$

## Phase II: Bound the defect

We use the SOLLYA package: RPA and sup-norm computation  
Chevallard, Joldes, Lauter

(a) Evaluate the code list of  $x' - f(t, x)$  with  $(U, [0, 0])$  in TM arithmetic

►  $i$ th component of the result is  $(p_i, r_i)$ :

$$\Delta U_i(t) - p_i(t) \in r_i \quad \text{for all } t \in [t_n, t_{n+1}]$$

(b) Compute a **rigorous enclosure**  $\mathbf{b}_i = [\underline{b}_i, \bar{b}_i]$ :

$$\underline{b}_i \leq \sup_{t \in [t_n, t_{n+1}]} |p_i(t)| \leq \bar{b}_i$$

Then, on  $[t_n, t_{n+1}]$ ,

$$\|\Delta U_i\|_\infty \leq \delta_i := \bar{b}_i + |r_i|, \quad |r_i| = \max\{|\underline{r}_i|, |\bar{r}_i|\}$$

We ensure  $\delta_i \leq \text{tol}$  for all  $i = 1, \dots, d$

## Example

Consider

$$x'(t) = f(t, x(t)) = x(t) - x(t)^2 \quad x(0) = 0.2$$

and

$$u(t) = 0.2 + 0.16t + 0.048t^2 + 1.0667 \times 10^{-3}t^3 \quad [t_0, t_1] = [0, 0.4]$$

First three coefficients exact; last rounded to 4 digits

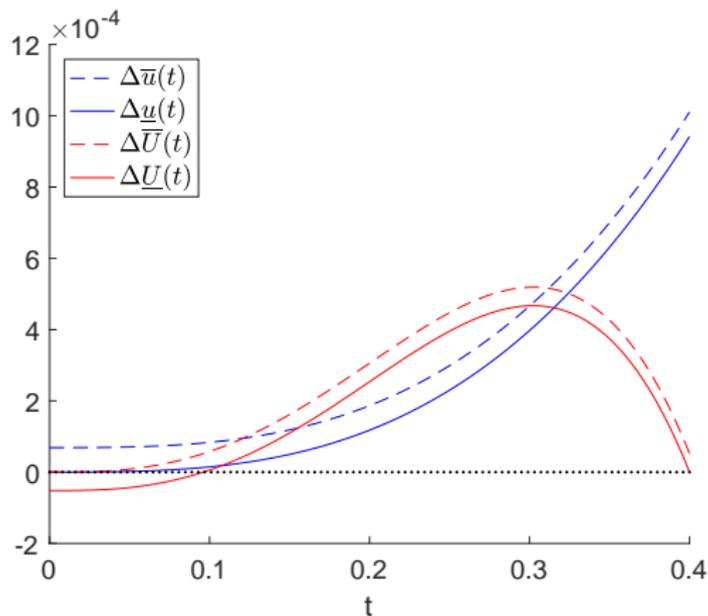
Interpolating  $f(t_1, u(t_1))$  (4 digits)

$$U(t) = v(t) + 1.5795 \times 10^{-2}t^4 - 3.9486 \times 10^{-2}t^5$$

Evaluating  $x' - (x - x^2)$  with  $(U, [0, 0])$ :  $\Delta U(t) - p(t) \in \mathbf{r}$  on  $[0, 0.4]$

$$p(t) = 1.3878 \times 10^{-17}t + 10^{-10}t^2 + 7.7898 \times 10^{-2}t^3 \\ - 2.0426 \times 10^{-1}t^4 + 2.8849 \times 10^{-2}t^5$$

$$\mathbf{r} = [-5.1923 \times 10^{-5}, 1.8090 \times 10^{-17}]$$

Figure 1: Enclosures of  $\Delta u(t)$  (blue) and  $\Delta U(t)$  (red)

## Phase III: Accept/reject step

We use “elementary controller”

$$(a) \quad \delta_{\max} = \max_i \delta_i, \quad \|\Delta u_i\|_{\infty} \leq \delta_i$$

If  $\delta_{\max} \leq \text{tol}$ , accept step and predict

$$h_{n+1} = 0.9h_n \left( \frac{0.5\text{tol}}{\delta_{\max}} \right)^{1/K} \quad K \text{ order of defect}$$

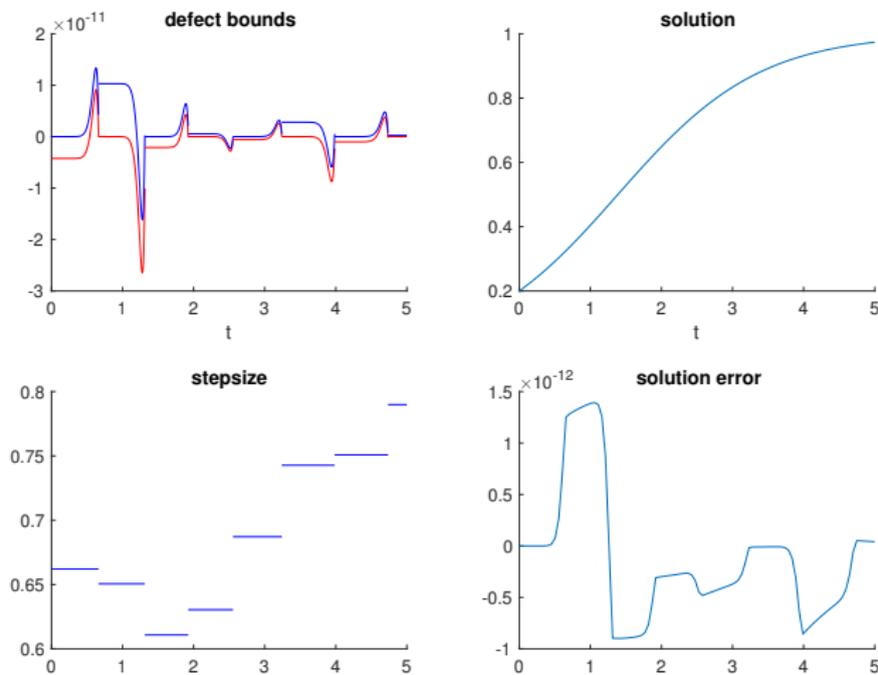
(b) else reject step and recompute  $\delta_{\max}$  with

$$h_n \leftarrow h_n \left( \frac{0.25\text{tol}}{\delta_{\max}} \right)^{1/K}$$

- ▶ That is, repeat from Phase I(b)
- ▶ This involves evaluating  $x' - f(t, x)$  in TM arithmetic
- ▶ Taylor coefficients are not recomputed

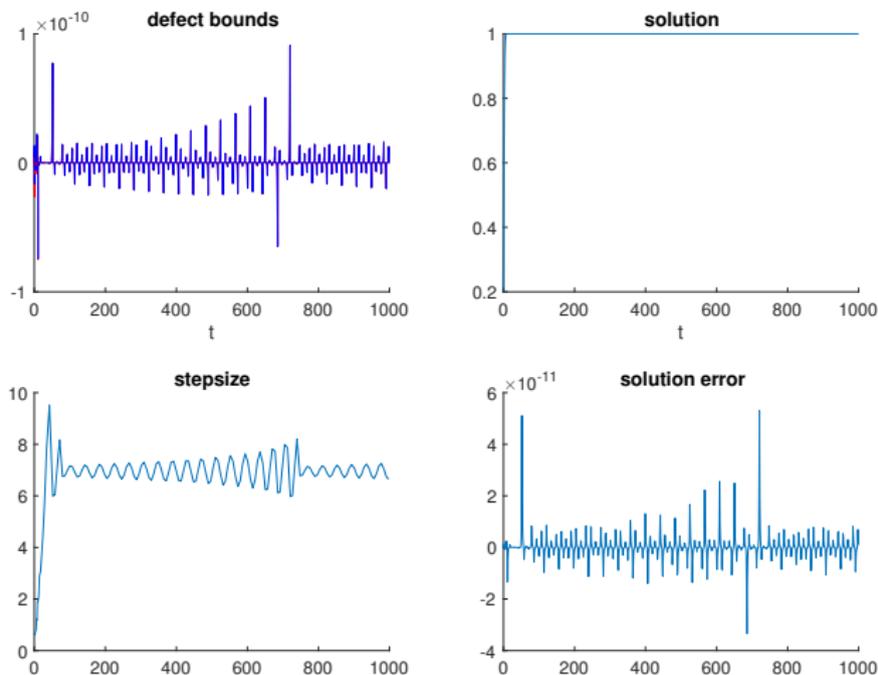
# Example: defect controlled $x' = x - x^2$ , $x(0) = 0.2$

Figure 2:  $t_{\text{end}} = 5$ , order 15,  $\text{tol} = 10^{-10}$



# Example: defect controlled $x' = x - x^2$ , $x(0) = 0.2$

Figure 3:  $t_{\text{end}} = 1000$ , order 15,  $\text{tol} = 10^{-10}$



## Why not interval arithmetic (IA) evaluation?

- ▶ Because is not very good
- ▶ IA evaluation: replace reals by intervals and execute in IA
- ▶ IA operations

$$\mathbf{a} \bullet \mathbf{b} = \{ a \bullet b \mid a \in \mathbf{a}, b \in \mathbf{b}, \text{ and } a \bullet b \text{ is defined} \}$$

- ▶ Evaluating  $\Delta u = u' - (u - u^2)$  in IA gives

$$u([0, 0.4]) \in \mathbf{u} = [0.2000, 0.2722]$$

$$u'([0, 0.4]) \in \mathbf{u}' = [0.1599, 0.2030]$$

$$\Delta u \in \mathbf{u}' - (\mathbf{u} - \mathbf{u}^2) = [-0.0722, 0.0771]$$

- ▶ Inexpensive to compute but the width of  $[-0.0722, 0.0771]$  is  $1.4917 \times 10^{-1}$   
Bounds can **blow up** for complicated  $f$ 's
- ▶ Width of  $\mathbf{r}$  is  $5.1923 \times 10^{-5}$   
TM keep bounds small

## ODETS: Putting it all together

### C++ implementation

- ▶ **ODETS** class implements the integration scheme
- ▶ User provides ODE function, e.g.

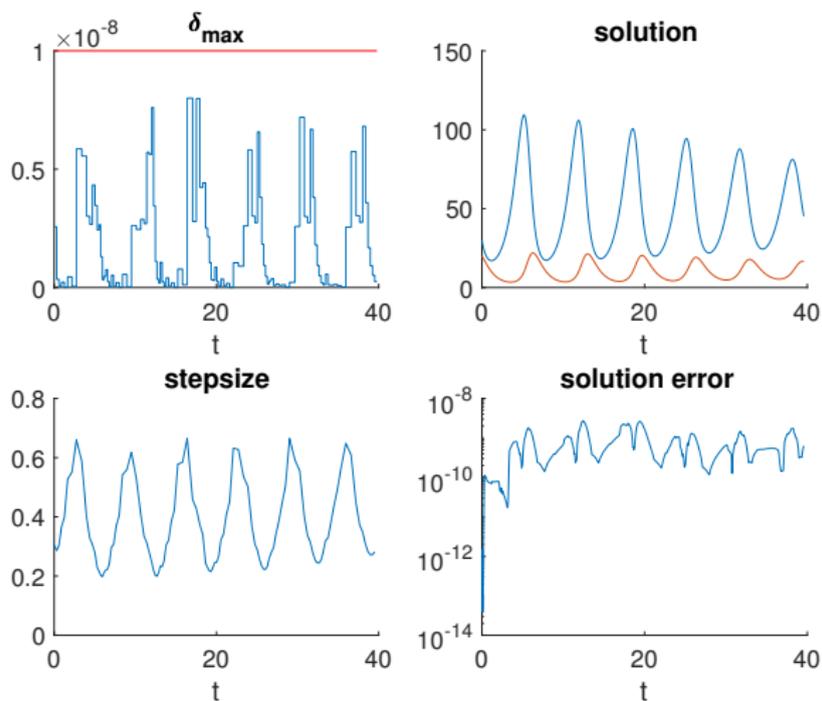
```

template <typename T>
void fcn( T t, const T * x, T * xp )
{
    xp[0] = x[0] - 0.1*x[0]*x[1] + 0.02*t;
    xp[1] = -x[1] + 0.02*x[0]*x[1] + 0.008*t;
}
  
```

- ▶ FADBAD++ uses **fcn** to generate computational graph
- ▶ Taylor coefficients are computed through FADBAD++
- ▶ **Tmodel** class interfaces SOLLYA and overloads arithmetic operators and elementary functions  
**fcn** is executed with **Tmodel** objects

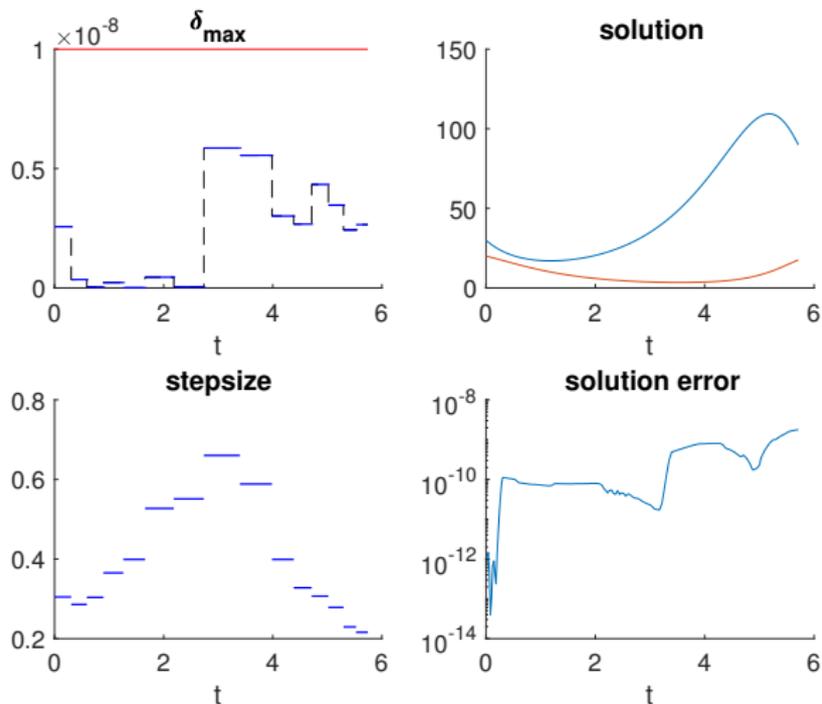
# Defect controlled Predator-Prey

Figure 5: Order 14,  $\text{tol} = 10^{-8}$



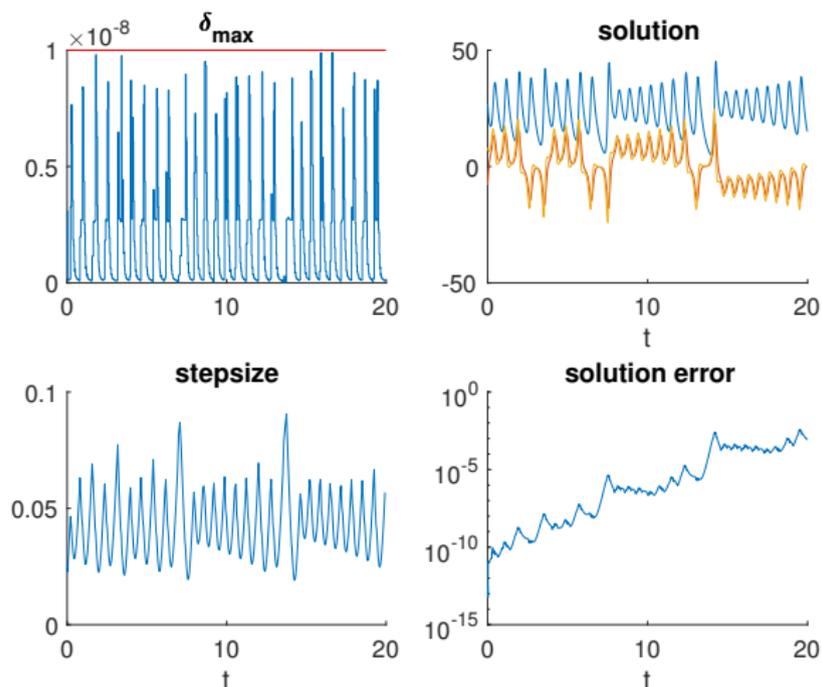
# Defect controlled predator-prey, zoom in

Figure 6: Order 14,  $\text{tol} = 10^{-8}$



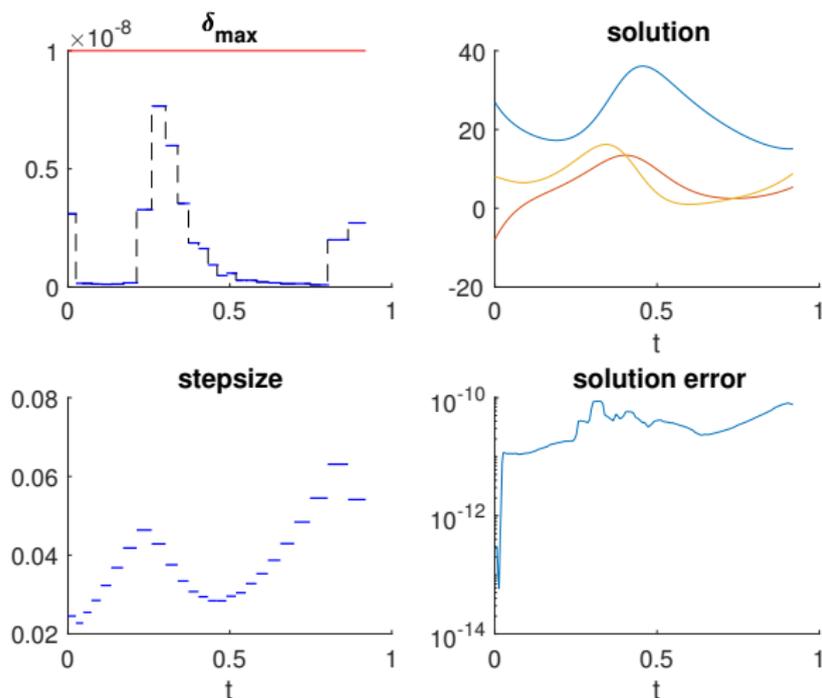
# Defect controlled Lorenz

Figure 7: Order 14,  $\text{tol} = 10^{-8}$



## Defect controlled Lorenz, zoom in

Figure 8: Order 14,  $\text{tol} = 10^{-8}$



## Accepted/rejected steps

- ▶ We can keep  $\delta_{\max}$  below tol
- ▶ We need to keep it closer to tol
- ▶ Generally, we can have too many stepsize rejections

order	tol	Lorenz $t_{\text{end}} = 20$		pred. prey $t_{\text{end}} = 40$	
		acc	rej	acc	rej
15	$10^{-6}$	356	79	80	23
	$10^{-8}$	465	65	103	20
	$10^{-10}$	612	25	135	15
	$10^{-12}$	814	2	179	15
20	$10^{-6}$	266	70	62	19
	$10^{-8}$	325	80	76	22
	$10^{-10}$	399	81	92	25
	$10^{-12}$	508	57	114	28

## Conclusions

- ▶ Defect encapsulates all errors, well studied problem in IA
- ▶ RPA provides better bounds than IA for residual-based backward error analysis
- ▶ Given Taylor model arithmetic and RPA for sup-norm of polynomial, get sup-norm for real-valued function
- ▶ We can bound the defect rigorously and guarantee it is within tolerance
- ▶ We need to understand stepsize control better, construct a better one